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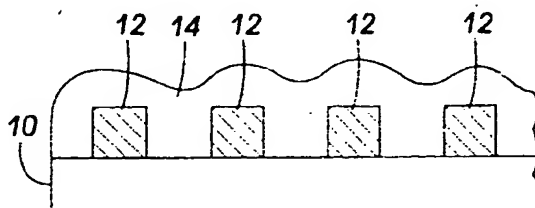
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**(54) Method and materials for fabricating an ink-jet printhead**

(57) An ink-jet printhead fabrication technique enables capillary channels for liquid ink to be formed with square or rectangular cross-sections. A sacrificial layer is placed over the main surface of a silicon chip, the sacrificial layer being patterned in the form of the void formed by the desired ink channels. A permanent layer,

comprising permanent material, is applied over the sacrificial layer, and, after polishing the two layers to form a uniform surface, the sacrificial layer is removed. Preferred materials for the sacrificial layer include polyimide while preferred materials for the permanent layer include polyarylene ether, although a variety of material combinations are possible.



**FIG. 2**

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## Description

The present invention relates to techniques and special materials for fabricating micromechanical devices, particularly ink-jet printheads, and to an ink-jet printhead made according to this technique.

In thermal ink-jet printing, droplets of ink are selectively ejected from a plurality of drop ejectors in a printhead. The ejectors are operated in accordance with digital instructions to create a desired image on a print sheet moving past the printhead. The printhead may move back and forth relative to the sheet in a typewriter fashion, or the linear array may be of a size extending across the entire width of a sheet, to place the image on a sheet in a single pass.

The ejectors typically comprise capillary channels, or other ink passageways, which are connected to one or more common ink supply manifolds. Ink is retained within each channel until, in response to an appropriate digital signal, the ink in the channel is rapidly heated and vaporized by a heating element (essentially a resistor) disposed on a surface within the channel. This rapid vaporization of the ink adjacent the channel creates a bubble which causes a quantity of ink to be ejected through an opening associated with the channel to the print sheet. One patent showing the general configuration of a typical ink-jet printhead is US patent no. 4,774,530.

In overview, a thermal ink-jet printhead such as of typical designs known in the art is a hybrid of a semiconductor and a micromechanical device. The heating elements are typically polysilicon regions doped to a particular resistivity, and the associated digital circuits for activating individual heating elements at various times are all well within the realm of semiconductor technology. Simultaneously, structures such as the capillary channels for retaining liquid ink and ejecting the ink from the printhead are mechanical structures which directly physically interface with the semiconductors such as the heating element or heater chip. For various reasons it is desirable to make mechanical structures such as the channel plate out of chemically etched silicon which is congruous with the semiconductor structure of the heater plate.

Using standard silicon-etching technology to create micromechanical structures, however, presents significant design constraints. Typically grooves in the channel plate, which are used to form capillary channels for the passage of ink therethrough, are typically most easily constructed with V-groove etching such as by applying a chemical etchant such as KOH to silicon. Because of the relative etching rates along different directions of a silicon crystal (the "aspect ratio"), etched cavities defining specific surface angles will result, forming the distinct V-grooves. When a channel plate defining etched V-grooves is abutted against a semiconductor heater chip, capillary channels which are triangular in cross-section are created. Such triangular cross-sections provide certain advantages, but are known to exhibit prob-

lems in directionality of ink droplets emitted therefrom; i.e., ink droplets are not always emitted straight out of the channel, but rather may be emitted at an unpredictable angle. It is likely that the performance of the chip could otherwise be improved if, for example, a cross-section which is closer to a square could be provided. However, the aspect ratio for the etching of silicon in typical etching processes would preclude creation of square-shaped grooves in a channel plate.

Another disadvantage of using V-grooves to form capillary channels is that it would be difficult to create, using V-groove etching, a channel which would vary in cross-section along the length of the channel. It would be difficult, for example, to create through V-groove etching a channel which increased or decreased in size along its length. In summary, while the V-groove etching technique has key practical advantages, there are also important design constraints associated with it.

The present invention describes a method, along with associated sets of material with which the method is preferably practiced, by which structures such as are useful in an ink-jet printhead can be created with more flexibility than with traditional V-groove etching techniques.

US-A-4,497,684 discloses a technique, using sacrificial layers, to deposit metal layers in a pattern on a substrate.

US-A-4,650,545 discloses a technique for making metal conductors which adhere to polyimide layers.

US-A-5,236,572 discloses a method for continuously manufacturing parts requiring precision micro-fabrication, such as ink-jet printheads.

US-A-5,296,092 discloses a planarization method for use with a semiconductor substrate.

US-A-5,322,594 discloses a method of manufacturing a one piece full-width ink-jet printing bar on a glass or ceramic plate.

US-A-5,378,583 discloses a technique for forming microstructures using a preformed sheet of photoresist.

US-A-5,401,983 discloses various techniques for monolithically integrating any thin film material or any device, including semiconductors.

US-A-5,454,904 discloses a micromachining method wherein a polyimide is utilized as a micromachinable material.

US-A-5,465,009 discloses techniques to permit lift-off, alignment and bonding of materials and devices. A device layer is deposited on a sacrificial layer situation on a growth substrate. The device layer is coated with a carrier layer. The sacrificial layer and/or the growth substrate are then etched away to release the combination of the device layer and carrier layer from the growth substrate.

According to the present invention, there is provided a method of fabricating a micromechanical device defining a cavity therein, such as an ink-jet printhead. A substrate defining a main surface is provided. A sacrificial layer of removable material, configured as a nega-

tive mold of the desired cavity, is deposited on the main surface. A permanent layer of permanent material is deposited over the main surface and the sacrificial layer. The permanent layer is polished to expose the sacrificial layer, and then the sacrificial layer is removed.

Figures 1-5 are a sequence of elevational views of capillary channels for an ink-jet printhead being formed on a silicon substrate;

Figure 6 is an elevational view of a more completed thermal ink-jet printhead made according to the technique of the present invention;

Figure 7 is a sectional plan view through line 7-7 in Figure 6, illustrating different channel shapes which may be formed with the technique of the present invention;

Figure 8 is a perspective view showing how the technique of the present invention can be used to form pits around heating elements in an ejector in a thermal ink-jet printhead; and

Figure 9 is a table showing known sets of materials which can be used to carryout the technique of the present invention in creating a thermal ink-jet printhead.

Figures 1-5 show a plan view of a portion of a semiconductor substrate having structures thereon, as would be used, for example, in creating a portion of a thermal ink-jet printhead. The successive Figures show the different steps in the method according to the present invention. In the Figures, like reference numerals indicate the same element at different stages in the process.

Figure 1 shows a semiconductor substrate 10 having disposed, on a main surface thereof, a series of sacrificial portions 12, which together can be construed as a single sacrificial layer. As shown in Figure 1, the individual sacrificial portions 12 are intended to represent a set of capillary channels for the passage of liquid ink therethrough in, for example, a thermal ink-jet printhead. As will be described below, the sacrificial portions 12 represent the configuration of voids (such as for capillary channels) in the finished printhead; the portions 12 can be construed as forming a negative of a mold. In the finished printhead, these capillary channels are intended to be disposed on the main surface of chip 10, in such a manner that the main surface of chip 10 serves as one wall of each capillary channel. In Figure 1, four separate and parallel channels are shown "end-on."

Different materials which can be used to create sacrificial layer 12 will be discussed in detail below, but, depending on the particular material selected, the sacrificial layer 12 can be deposited in a desired pattern on the main surface of chip 10 using any number of a familiar techniques, such as laser etching, chemical etching, or photoresist etching.

In Figure 2 is shown the placement of a permanent layer 14 over the portions 12 of the sacrificial layer. Per-

manent layer 14 will ultimately be used to define the voids which, in Figure 2, are occupied by sacrificial layers 12. It will be noted that, in the illustrated embodiment, the parallel-channel pattern of sacrificial layer 12 causes an undulating surface to be created by permanent layer 14. The permanent layer 14 can be deposited by any number of available techniques, such as spin casting, spray coating, screen printing, CVD or plasma deposition. A detailed discussion of what materials are most suited for permanent layer 14 will be given below.

In Figure 3 the permanent layer 14, which has been hardened to a solid, has been mechanically polished in such a manner that a single flat surface is obtained, with different areas thereof being formed by portions of permanent layer 14 or exposed portions of sacrificial layer 12. Depending on the particular materials selected for layers 12 and 14, this polishing step can be carried out by any of a variety of known techniques, such as mechanical polishing or laser ablation.

In Figure 4 the sacrificial layer, represented in previous Figures by portions 12, has been removed. According to a preferred embodiment of the present invention, this removal of sacrificial layer 12 is carried out by chemical etching, although other techniques may be possible. It can be seen that there are now precisely-shaped channels where the sacrificial layers 12 used to be. These channels can in turn be used for passage and retention of liquid ink, such as a thermal ink-jet printhead. It will further be noted that substantially right angles can be provided between the walls of permanent layer 14 and the "floor" formed by the main surface of chip 10 within each channel. This is shown in contrast to previous typical designs of ink-jet printheads, using V-groove etching, wherein only triangular-cross-section channels are practical.

Figure 5 shows a possible subsequent step in the process of the present invention, wherein further structures can be provided on the remaining portions of the permanent layer 14. As shown, a second sacrificial layer 16 can be placed in various ways over the permanent layer 14, such as by placing the sacrificial layer 16 entirely over a portion of permanent layer 14, or else, as shown toward the right of Figure 5, placing a portion of the sacrificial layer 16 over permanent layer 14 or over the remaining exposed main surface of chip 10. The steps shown in Figures 1-4 can thus be repeated over the existing permanent layers 14 in order to create fairly sophisticated three-dimensional structures. Alternately, multiple permanent layers of the same general plan design can be "stacked" on top of each other, thereby creating "trenches" having a high aspect ratio of height to width. The only significant constraint on creation of structures in higher layers is that there should be access for "buried" sacrificial layers, whereby removal chemicals can be applied to lower sacrificial layers, or the dissolved substance of sacrificial layers may be drained out.

Figure 6 is an elevational view of a substantially fin-

ished ink-jet printhead exploiting, for example, the structure shown in Figure 4. It will be noted that the semiconductor substrate 10 has defined therein (such as through semiconductor fabrication means known in the art) a series of heating elements 24 on which the channels formed by permanent layer 14 are aligned. As is known in the art of thermal ink-jet printing, application of a voltage to a heating element such as 24 will cause nucleation of the liquid ink being retained in the channel, which in turn causes the liquid ink to be ejected from the channel and onto a print sheet. (More broadly, the heating element 24 could be replaced with another kind of structure to energize the liquid ink and cause ejection of ink from the channel, such as a piezoelectric structure; in the claims hereinbelow, a heating or other structure is generalized as an "energizing surface.") Disposed over the "top" surface provided by permanent layer 14 is a simple plane layer 20, which in effect completes the channels formed by semiconductor substrate 10 and the walls of permanent layer 14 so that enclosed (but open-ended) capillary channels are created. Typically, plane layer 20 need not have any particular sophisticated structure associated therewith, and can be made of an inexpensive ceramic, resin, or metal.

Figure 7 is a plan view showing how the technique of the present invention can, by virtue of using permanent layer 14 to facilitate channel shapes which vary in cross-section along the length thereof, to an extent that is impossible with channels which are created in directly etched grooves. The channels are created by placing on the substrate sacrificial layers 12 which are shaped like the desired channels in the finished printhead. Figure 7 merely shows three possible examples of such odd-shaped channels: of course, all of the channels would be of the same general design in a practical printhead. However, as shown, the various possible shapes of the channels created by permanent layer 14 facilitate shapes which can be optimized relative to, for example, the position of the heating element 24 in semiconductor chip 10.

Figure 8 is a perspective view of an ejector made according to the technique of the present invention, showing an important printhead design which can be readily enabled with the technique of the present invention. In a printhead in which a heating element 24, such as shown in Figure 7, is defined within a heater chip 10, permanent layer 14 can be used not only to define an ejector channel, but also to form a pit, indicated as 25, which is spaced around, or closely to, the perimeter of the surface of heating element 24. This pit 25 is known in the art as a structure which can improve the performance of a thermal ink-jet ejector by providing a specific zone for ink nucleation. In prior art printheads, such pits such as 25 are formed in their own separate layers, such as a polyimide, which must be provided to the printhead chip in a separate manufacturing step. With the technique of the present invention, however, a structure defining a pit 25 around every heating element 24 can be

formed in a single piece with the rest of the sides of the ejector, by permanent layer 14. That is, the present invention enables structure defining pit 25 to be formed out of essentially the same layer of material that defines the walls of the ejector itself. Formation of this pit 25 in permanent layer 14 can be performed by multiple iterations of the sacrificial layer technique as shown in Figure 5.

Although, in the illustrated embodiment, the negative-mold technique is used for the creation of capillary channels in a thermal ink-jet printhead, the technique can be used to form other types of cavities in a printhead, such as to make the ink-supply manifolds through which ink is supplied to the channels in the printhead. Broadly, the technique of the present invention can be applied to making any specially-shaped void in a micro-mechanical apparatus, and can readily be applied to the creation of voids having a critical dimension (i.e. along a dimension parallel to the main surface of the substrate) from about 3 micrometers to about one centimeter.

Having demonstrated the basic steps of the technique of the present invention, attention is now directed to specific combinations of materials which can be used for sacrificial layer 12 and permanent layer 14. The specific selection of a combination of such material will depend not only on cost and ease of use for obtaining a particular shape of permanent layer 14, but must inevitably take into account the specific requirement for an entire printhead, namely the composition of liquid inks which are likely to be used with the printhead. Because of various competing concerns such as ink drying and clogging, etc., it is fairly common that liquid inks used in ink-jet printing have characteristics such as acidity or baseness; these qualities have been known to cause degradation of common materials used in printheads. Also, other inks are nucleophilic, which further limits the choice of materials for a printhead.

Figure 9 is a table giving, in general terms, various preferred combinations of sacrificial layer material, permanent layer material, sacrificial layer patterning methods, and dissolving chemicals, representing various practices of the invention known to the inventors as of the time of filing. In brief, the necessary attributes of a sacrificial material is that it be patternable (either by being photosensitive itself, or being patternable by the application of a photoresist), and removable (such as by wet or plasma chemical etching, ion bombardment, or ablation). Necessary attributes of the permanent material, in the ink-jet printing context, are that the material be resistant to the common corrosive properties of ink, (such as acid/base, nucleophilic, or otherwise reactive), should exhibit temperature stability, and be relatively rigid so that, if necessary in certain manufacturing processes, the created structures are diceable (that is, if a large number of printhead chips are made in a single wafer, the wafer must be able to be cut into individual chips). While various combinations of various materials

and methods have been shown to be practical, the choice of which particular combination is a "best mode" will depend on external factors, such as the choice of ink used in the printhead, as well as cost. On the whole, the most versatile materials for permanent layers in the ink-jet printing context are polyarylene ether or polyimide.

In one embodiment of the claimed invention, different types of polyimide can be used respectively for the sacrificial and permanent layers. If two types of polyimide are used, the polyimide used for the sacrificial layer should be a partially-cured polyimide, while the polyimide for the permanent layer should be a fully-cured polyimide. Alternately, the polyimide used for sacrificial layer should be a base-sensitive polyimide, while the polyimide for the permanent layer should be a less base-sensitive polyimide.

The table of Figure 9 lists certain proprietary substances such as those known under the trademarks of RISTON® and VACREL®, both available from E. I. du Pont De Nemours & Company. In the claims hereinbelow, these proprietary materials are referred to as "dry-film solder masks."

In the context of manufacturing ink-jet printheads, a single layer of permanent material 14 can be readily created up to a thickness of 60 micrometers. Such a layer will still exhibit the desirable right-angle relationship between the walls of the permanent layer such as 14 and the surface of the silicon substrate 10. However, by using multiple iterations of the present method, such as shown in Figure 5, the thickness of such a permanent layer 14 comprising several such layers could easily reach into the tens of millimeters. The thickness of structures created by one or more permanent layers 14 is fundamentally constrained only by the mechanical stability of such walls, i.e., a wall created by permanent layer 14 need only be thick enough to support itself in a particular situation.

Further information regarding the preparation of polyarylene ethers and the like is disclosed in, for example, P. M. Hergenrother, *J. Macromol. Sci. Rev. Macromol. Chem.*, **C19**(1), 1-34 (1980); P. M. Hergenrother, B. J. Jensen, and S. J. Havens, *Polymer*, **29**, 358 (1988); B. J. Jensen and P. M. Hergenrother, "High Performance Polymers," Vol. 1, No. 1) page 31 (1989), "Effect of Molecular Weight on Poly(arylene ether ketone) Properties"; V. Percec and B. C. Auman, *Makromol. Chem.* **185**, 2319 (1984); "High Molecular Weight Polymers by Nickel Coupling of Aryl Polychlorides," I. Colon, G. T. Kwaikowski, *J. of Polymer Science, Part A, Polymer Chemistry*, **28**, 367 (1990); M. Ueda and T. Ito, *Polymer J.*, **23** (4), 297 (1991); "Ethyne-Terminated Polyarylates: Synthesis and Characterization," S. J. Havens and P. M. Hergenrother, *J. of Polymer Science: Polymer Chemistry Edition*, **22**, 3011 (1984); "Ethyne-Terminated Polysulfones: Synthesis and Characterization," P. M. Hergenrother, *J. of Polymer Science: Polymer Chemistry Edition*, **20**, 3131 (1982); K. E. Dukes, M. D. Forbes,

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## Claims

1. A method of fabricating a micromechanical device defining a cavity therein, comprising the steps of:
  - providing a substrate (10) defining a main surface;
  - depositing on the main surface a sacrificial layer (12) of a first material, configured as a negative mold of the cavity;
  - depositing over the sacrificial layer a permanent layer (14) of a second material;
  - polishing the permanent layer (14) to expose the sacrificial layer (12); and
  - removing the sacrificial layer (12).
2. The method of claim 1, wherein the substrate (10) defines a heating surface.
3. The method of either of claims 1 or 2, wherein the

step of depositing on the main surface a sacrificial layer (12) comprises the step of depositing the sacrificial layer (12) whereby edges of the sacrificial layer (12) form substantially right angles with the main surface of the substrate (10). (24) of the energizing surface.

4. The method of any of claims 1 to 3, comprising the further steps of

depositing on the permanent layer (14) a second sacrificial layer (16); and  
depositing over the second sacrificial layer (16) a second permanent layer.

5. The method of any of claims 1 to 4, wherein a cavity formed as a negative mold in the sacrificial layer (12) has a dimension parallel to the main surface not less than about 3 micrometers and not more than about one centimeter.

6. The method of any of claims 1 to 5, wherein said first material is selected from the group consisting of a dry-film solder mask, a plasma nitride, a plasma oxide, a spin-on glass, a polyimide, RISTON, and VACREL.

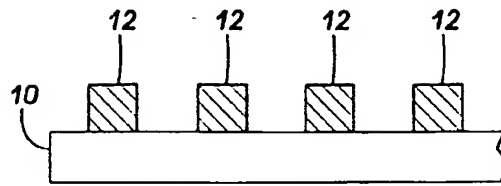
7. The method of any of claims 1 to 6, wherein said second material is selected from the group consisting of a probimer, a benzocyclobutene, silicon dioxide,  $\text{Si}_3\text{N}_4$ , a polyphenylene, a polyarylene ether and a phenolphthalein containing arylene ether.

8. A method of fabricating an ink-jet printhead defining a plurality of channels therein, comprising the steps of:

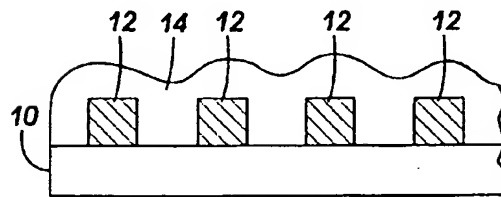
providing a substrate (10) defining a main surface;  
depositing on the main surface a sacrificial layer (12) of a first material, configured as a negative mold of the plurality of channels;  
depositing over the sacrificial layer a permanent layer (14) of a second material; and  
removing the sacrificial layer (12).

9. The method of claim 8, the substrate (10) defining a plurality of energizing surfaces in the main surface thereof, each energizing surface corresponding to one channel in the printhead, and wherein the step of depositing on the main surface a sacrificial layer (12) comprises the step of depositing the sacrificial layer (12) over the energizing surface.

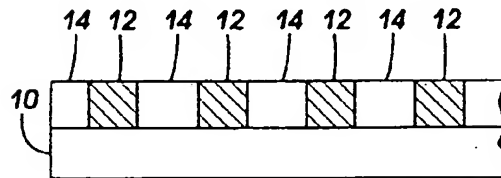
10. The method of claim 9, wherein the step of depositing the sacrificial layer (12) includes depositing the sacrificial layer (12) within a perimeter (24) of the energizing surface, thereby allowing the permanent layer (14) to form a pit (25) around the perimeter



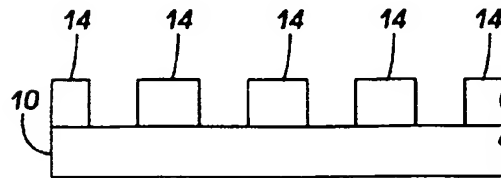
**FIG. 1**



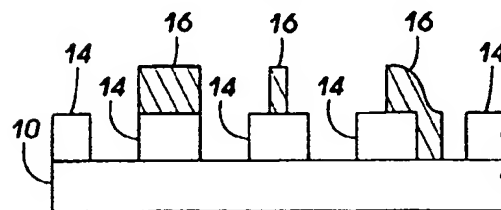
**FIG. 2**



**FIG. 3**



**FIG. 4**



**FIG. 5**

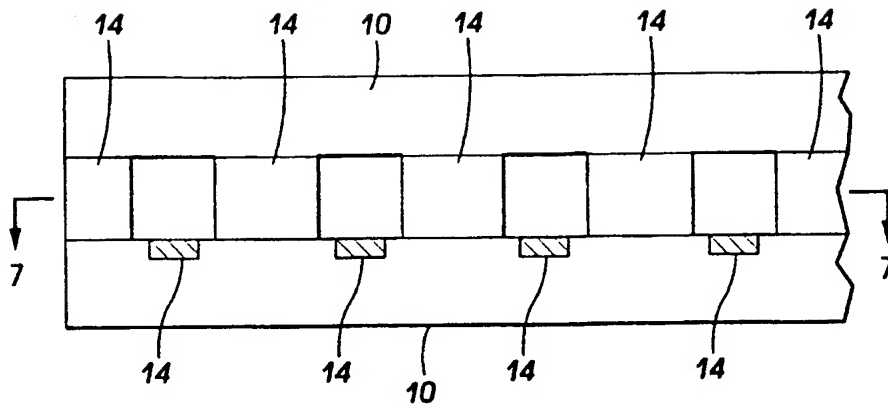


FIG. 6

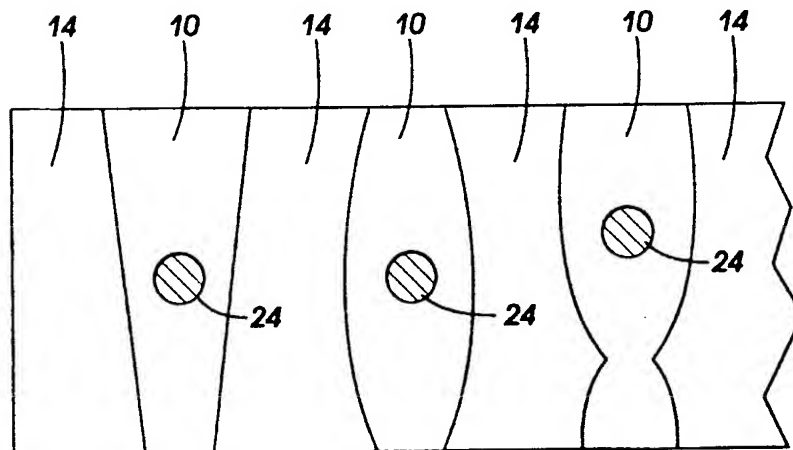


FIG. 7



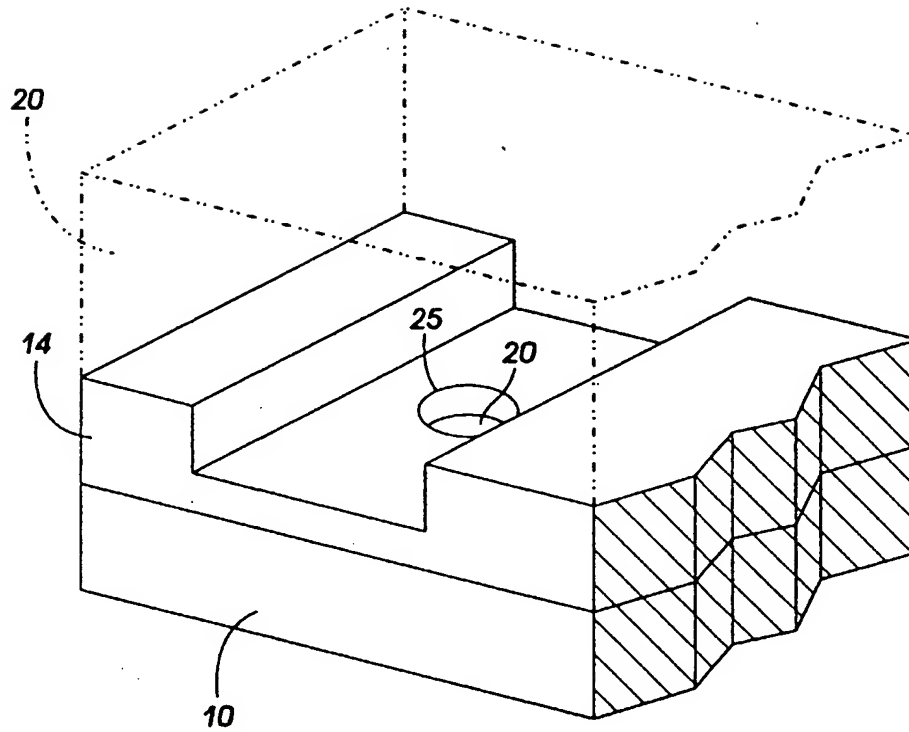


FIG. 8

SACRIFICIAL LAYER (SL)	SL PATTERNING METHOD	PERMANENT LAYER	DISSOLVING CHEMICAL
PMDA-ODA POLYIMIDE	PHOTOPATTERN	POLYIMIDE	KOH, BASES, OR NUCLEOPHILIC AGENTS
RISTON®, VACREL®	PHOTOPATTERN	POLYIMIDE	METHYLENE CHLORIDE
PLASMA NITRIDE OR OXIDE, SPIN ON GLASS	WET OR PLASMA ETCH	POLYIMIDE	HF, H <sub>3</sub> PO <sub>4</sub>
RISTON®, VACREL®, POLYIMIDE	PHOTOPATTERN	POLYPHENYLENES, PHENOLPHTHALEIN-CONTAINING ARYLENE ETHERS, PROBIMER, BENZOCYCLOBUTENES	METHYLENE CHLORIDE, KOH, NMP
PHOTORESIST	PLASMA ETCH OR PHOTOPATTERN	ABOVE MATERIALS	RESIST STRIPPER, BASES
PHOTORESIST OR POLYIMIDE	PHOTOPATTERN	SiO <sub>2</sub> , Si <sub>3</sub> N <sub>4</sub>	PLASMA ASH, STRIPPER
POLYIMIDE OR ANY OF THE ABOVE	AS NEEDED FOR SL	POLYARYLENE ETHER	AS NEEDED FOR SL
PSG	PHOTORESIST WITH WET OR DRY ETCH	POLYIMIDE	HF

FIG. 9